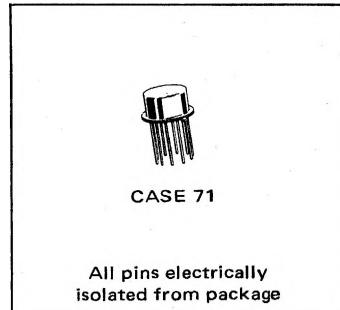


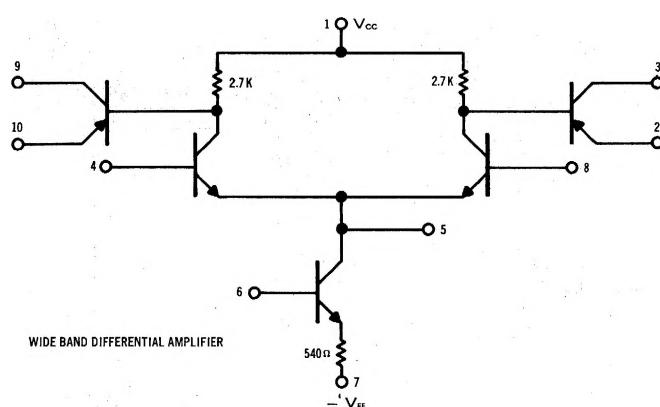
DIFFERENTIAL AMPLIFIER**DIFFERENTIAL AMPLIFIERS****MC1519**

. . . featuring NPN inputs and PNP outputs. Two monolithic compatible* chips are used to provide a versatile and extremely stable amplifier.

*Compatible — a process utilizing thin film resistors deposited on a silicon monolithic integrated circuit.

**MAXIMUM RATINGS** ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
Power Supply Voltage	V_{CC}	+14	Vdc
Power Supply Voltage	V_{EE}	-14	Vdc
Differential Input Signal	V_{in}	± 5	Vdc
Total Power Dissipation Derate above 25°C	P_D	300 2.0	mW mW/ $^\circ\text{C}$
Operating Temperature Range	T_J	-55 to +125	$^\circ\text{C}$
Storage Temperature Range	T_{stg}	-65 to +175	$^\circ\text{C}$

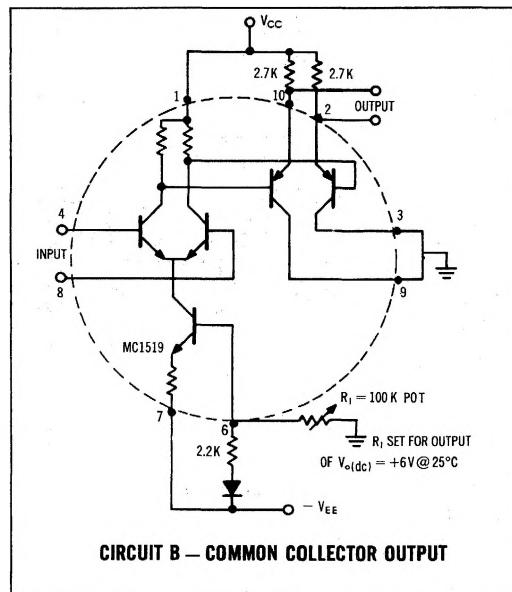
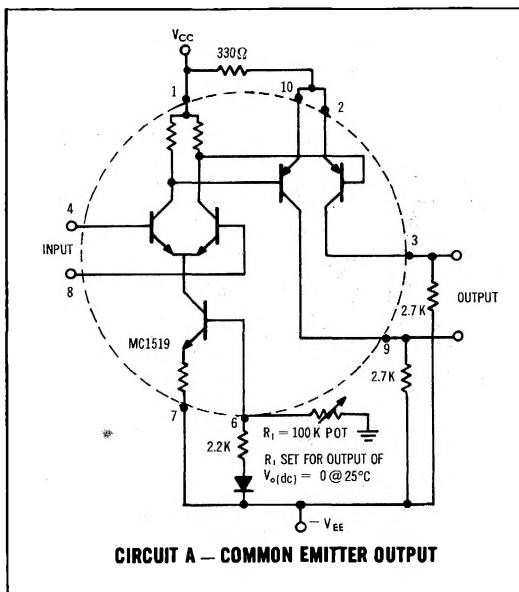
CIRCUIT SCHEMATIC

MC1519 (continued)

ELECTRICAL CHARACTERISTICS ($V_{CC} = +12 \text{ Vdc}$, $V_{EE} = -12 \text{ Vdc}$, $T_A = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Figure No.	Symbol	Min	Typ	Max	Unit
Differential Voltage Gain Circuit A (CE) Circuit B (CC)	3, 8	A_{dd}	67 40	73 45	79 50	db
Single Ended Voltage Gain Circuit A (CE) Circuit B (CC)	3	A_V	— —	67 38	— —	db
Maximum Output Swing Circuit A (CE) Circuit B (CC)	4	V_O	12.0 8.0	14.0 10.0	— —	$\text{V}_{(\text{p-p})}$
Input Offset Voltage Circuit A (CE) Circuit B (CC)	5, 9	V_{IO}	— —	2.0 2.0	6.0 6.0	mVdc
Input Offset Voltage Drift Circuit A (CE) Circuit B (CC)	5, 9	V_{IOD}	— —	5.0 5.0	— —	$\mu\text{V}/^\circ\text{C}$
Input Offset Current Circuit A (CE) Circuit B (CC)	6, 10	I_{IO}	— —	1.0 2.0	4.0 8.0	μAdc
Input Current Circuit A (CE) Circuit B (CC)	6, 11	I_i	— —	40.0 60.0	70.0 90.0	μAdc
Common Mode Rejection Circuit A (CE) Circuit B (CC)	7	CM_{Rej}	— —	89.0 86.0	— —	db
Bandwidth - 3 db Circuit A (CE) Circuit B (CC)	3, 12	BW	0.70 5.0	1.0 8.0	— —	mc
Differential Input Impedance Circuit A (CE) Circuit B (CC)	2	Z_{in}	1.8 —	2.6 1.2	— —	kohms
Single Ended Output Impedance Circuit A (CE) Circuit B (CC)	2	Z_{out}	— —	2.7 0.048	— 0.120	kohms

FIGURE 1



MC1519 (continued)

TEST CIRCUITS

FIGURE 2 — DIFFERENTIAL INPUT IMPEDANCE AND SINGLE-ENDED OUTPUT IMPEDANCE

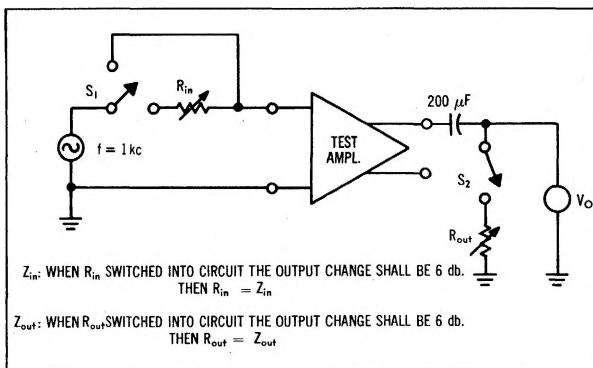


FIGURE 3 — DIFFERENTIAL VOLTAGE GAIN, SINGLE-ENDED VOLTAGE GAIN, and BANDWIDTH

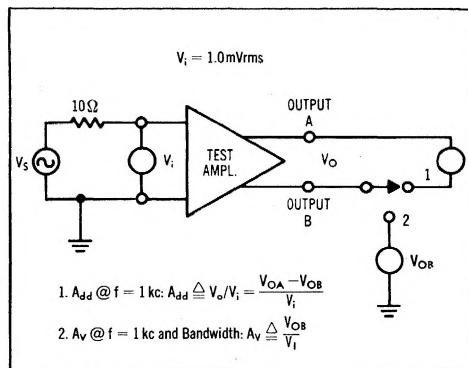


FIGURE 4 — MAXIMUM OUTPUT SWING

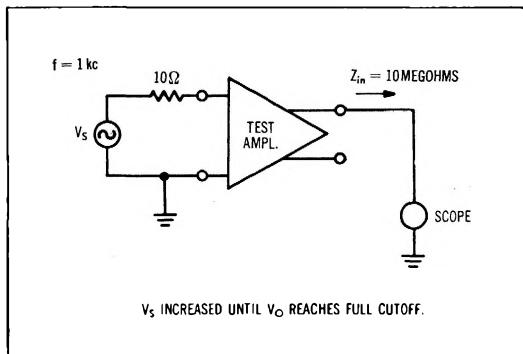


FIGURE 5 — INPUT OFFSET VOLTAGE

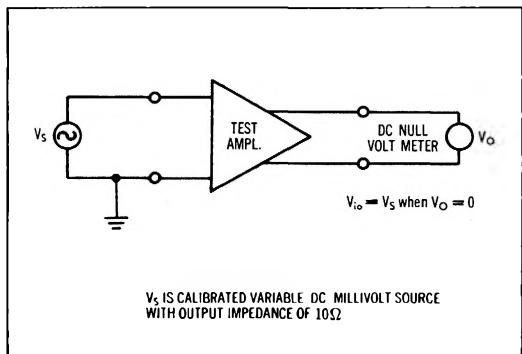


FIGURE 6 — INPUT OFFSET CURRENT and INPUT CURRENT

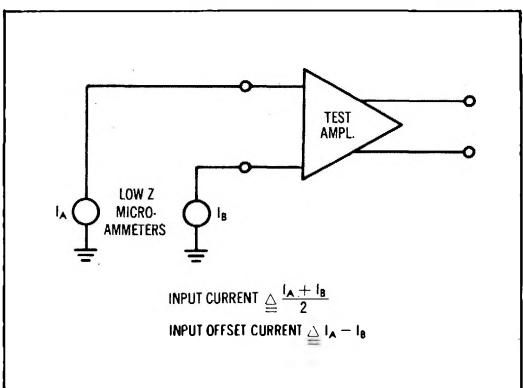
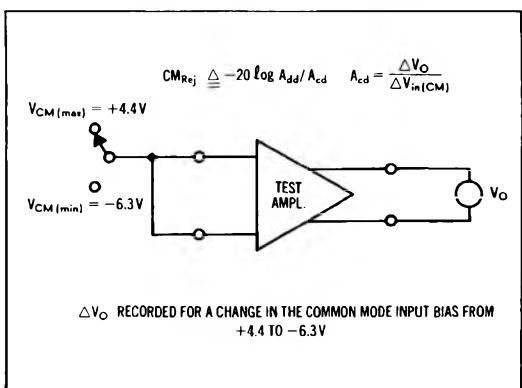


FIGURE 7 — COMMON MODE REJECTION



MC1519 (continued)

EFFECT OF TEMPERATURE ON CIRCUIT B CHARACTERISTICS

R, SET FOR $V_{O(OM)} = +6V$ AT $+25^{\circ}\text{C}$

FIGURE 8 — DIFFERENTIAL MODE GAIN

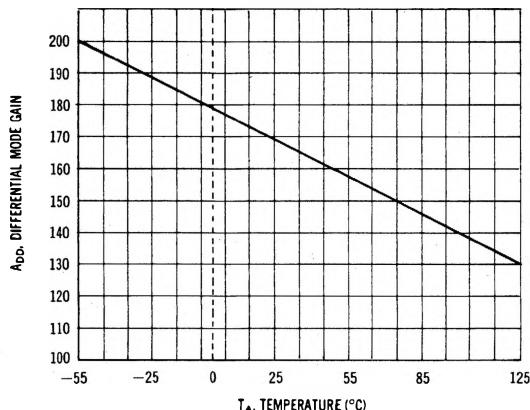


FIGURE 9 — INPUT OFFSET VOLTAGE

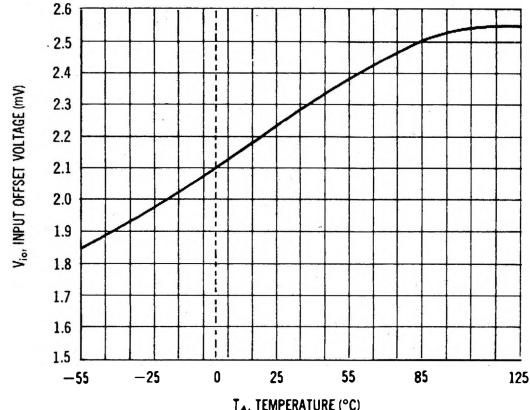


FIGURE 10 — INPUT OFFSET CURRENT

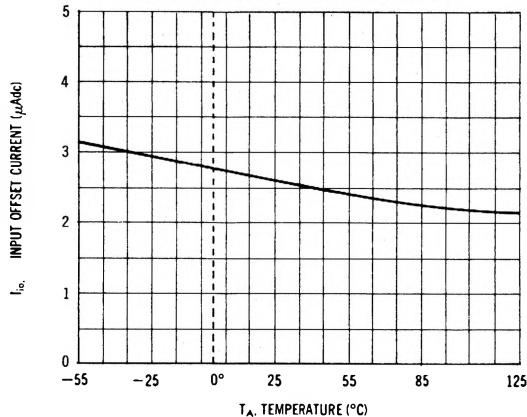


FIGURE 11 — INPUT CURRENT

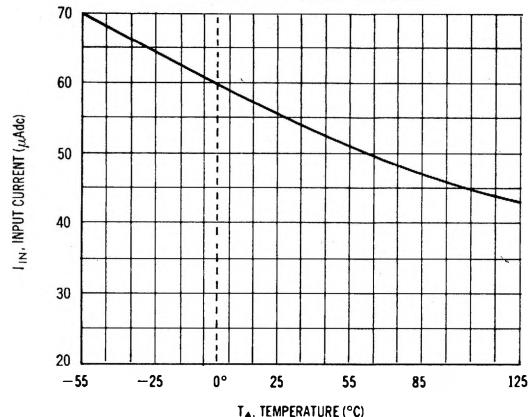


FIGURE 12 — CIRCUIT A BANDWIDTH

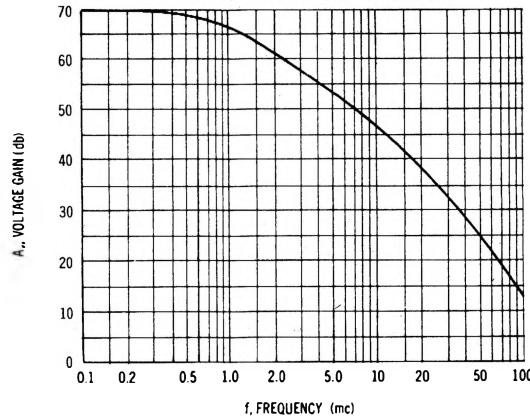


FIGURE 13 — CURRENT SOURCE BIASING

